

Search Notes

Application/Control No.

10/757,253

Examiner

Hsien-ming Lee

Applicant(s)/Patent under
Reexamination

EPPICH ET AL.

Art Unit

2823

SEARCHED

Class	Subclass	Date	Examiner
438	244,253	1/25/2006	LEE
438	396,630	1/25/2006	LEE
438	649	1/25/2006	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	244,253	1/25/2006	LEE
438	396,630	1/25/2006	LEE
438	649	1/25/2006	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST attached (USPAT, USPG, USOCR, EPo, JPO, IBM, Derwent)	1/25/2006	LEE